Application/Control No. Applicant(s)/Patent Under Reexamination 10/056,471 ECKERT ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Nicholas D. Rosen 3625 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY * US-2002/0019761 A1 Α 02-2002 Lidow, Derek 705/10 US-2002/0069121 A1 В 06-2002 Jain et al. 705/26 С US-2002/0099638 A1 07-2002 Coffman et al. 705/37 * D US-2002/0111894 A1 08-2002 Stevens, Robert G. 705/37 Ε US-2003/0110054 A1 06-2003 Lindquist, C. William 705/1 * F US-2004/0039650 A1 02-2004 Lentz, Nathanael 705/26 G US-Н US-US-١ J US-US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Country Code-Number-Kind Code MM-YYYY Classification N JP-2001-357314-A 12-2001 Japan Kato 0 Р Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Х